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**Technical requirements of automatic inspection system for
surface defect of industrial product**

工业产品表面缺陷自动检测系统技术要求

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Table of Contents

Foreword
1 Scope
2 Normative references
3 Terms and definitions
3.1 Surface imperfection
3.2 machine learning
3.3 neuralnetwork
4 Abbreviations
5 Architecture and workflow of industrial product surface automatic inspection system
5.1 System Architecture

Foreword

This document is in accordance with the provisions of GB/T 1.1-2020 "Guidelines for standardization work Part 1: Structure and drafting rules for standardization documents" Drafting.

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Technical requirements for automatic detection system of surface defects of industrial products

1 Scope

This document specifies the architecture and composition of the industrial product surface defect automatic detection system, system functional requirements, automatic detection core technology, Testing process and deployment and integration technical requirements.

This document is applicable to the construction and application of automatic detection system for surface defects of industrial products based on deep neural network technology.

2 Normative references

This document has no normative references.

3 Terms and definitions

The following terms and definitions apply to this document.

3.1 Surface imperfection

Units, groups of units, or irregularities in the actual surface that are generated unintentionally or accidentally during processing, storage, or use.

[Source: GB/T 40810.1-2021, 3.12]

3.2 machine learning

The process by which a functional unit improves its performance by acquiring new knowledge or skills, or by organizing existing knowledge or skills.

[Source: GB/T 5271.31-2006, 2.31.01.02]

3.3 neuralnetwork

A network of basic processing elements connected by weighted paths with adjustable weights, which makes each element Each unit generates a value and transmits it to other units or represents it as an output value.

[Source. GB/T 5271.34-2006, 34.01.06]

4 Abbreviations

The following abbreviations apply to this document. CCD. Charge-coupled Device

5.1 System Architecture

The architecture of the automatic detection system for industrial product surface defects is shown in Figure 1.